



AO6806

Dual N-Channel Enhancement Mode Field Effect Transistor

General Description

The AO6806 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications. AO6806 is Pb-free (meets ROHS & Sony 259 specifications).

Features

 $V_{DS} = 20V$

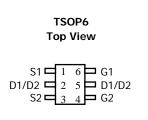
 $I_D = 5.0A$ ($V_{GS} = 4.5V$)

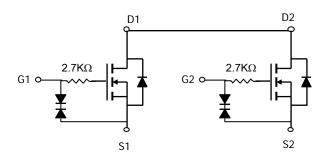
 $R_{DS(ON)}$ < 33m Ω (V_{GS} = 4.5V)

 $R_{DS(ON)} < 34m\Omega (V_{GS} = 4.0V)$

 $R_{DS(ON)}$ < 36m Ω (V_{GS} = 3.1V)

 $R_{DS(ON)}$ < 40m Ω (V_{GS} = 2.5V)





Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	10 Sec	Steady State	Units		
Drain-Source Voltage		V_{DS}	20		V		
Gate-Source Voltage		V_{GS}	±12		V		
Continuous Drain	T _A =25°C		5	3.8			
Current ^A	T _A =70°C	I _D	3.8	3	Α		
Pulsed Drain Current ^B		I _{DM}	25				
Power Dissipation ^A	T _A =25°C	D	1.3	0.8	W		
	T _A =70°C	$-P_{D}$	0.8	0.5	VV		
Junction and Storage Temperature Range		$T_{\rm J}, T_{\rm STG}$	-55 to 150		°C		

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	≤ 10s		95	°C/W			
Maximum Junction-to-Ambient A	Steady State	$R_{\scriptscriptstyle{ hetaJA}}$	118	150	°C/W			
Maximum Junction-to-Lead ^C	Steady State	$R_{ hetaJL}$	54	68	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 20V, V _{GS} = 0V			1	
		$T_J = 55$ °C			5	μА
I_{GSS}	Gate-Body leakage current	$V_{DS} = 0V$, $V_{GS} = \pm 10V$			±10	μΑ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = 250 \mu A$	0.5	0.7	1	V
$I_{D(ON)}$	On state drain current	$V_{GS} = 4.5V, V_{DS} = 5V$	25			Α
		$V_{GS} = 4.5V, I_D = 5.0A$	21	27	33	mΩ
		T _J =125°C	29	37	45	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 4.0V, I_D = 4.5A$	22	28	34	mΩ
		$V_{GS} = 3.1V, I_D = 4.5A$	24	30	36	mΩ
		$V_{GS} = 2.5V, I_D = 4.0A$	26	33	40	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 5V, I_{D} = 5.0A$		18		S
V_{SD}	Diode Forward Voltage	$I_S = 1A, V_{GS} = 0V$		0.65	1	V
I _S	Maximum Body-Diode Continuous Current				1.3	Α
DYNAMIC	PARAMETERS					
C _{iss}	Input Capacitance			180	225	pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz		95		pF
C _{rss}	Reverse Transfer Capacitance]		18		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		2.7	4	kΩ
SWITCHI	NG PARAMETERS					
Q _g (4.5V)	Total Gate Charge			5.6	7.5	nC
Q_{gs}	Gate Source Charge	V_{GS} = 4.5V, V_{DS} = 10V, I_{D} = 5A		0.85		nC
Q_{gd}	Gate Drain Charge]		1.7		nC
t _{D(on)}	Turn-On DelayTime			172		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =10V, R_L =2.0 Ω ,		368		ns
t _{D(off)}	Turn-Off DelayTime	R_{GEN} =3 Ω		2.94		μS
t _f	Turn-Off Fall Time]		2.5		μS
t _{rr}	Body Diode Reverse Recovery Time	I _F =5A, dI/dt=100A/μs		32	43	ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =5A, dI/dt=100A/μs		3.2		nC

A: The value of R $_{0JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ = 25°C. in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

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C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using < 300 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

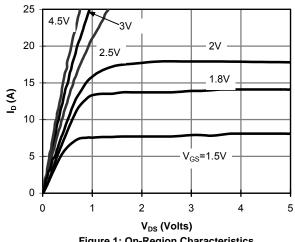


Figure 1: On-Region Characteristics

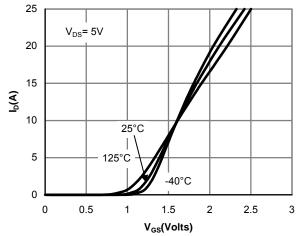


Figure 2: Transfer Characteristics

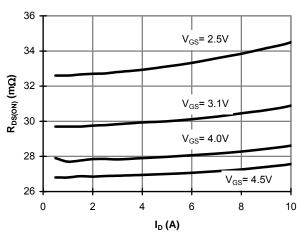


Figure 3: On-Resistance vs. Drain Current and **Gate Voltage**

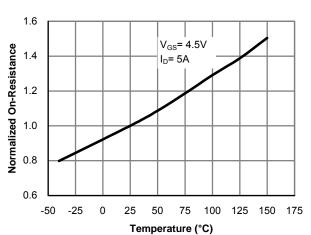


Figure 4: On-Resistance vs. Junction Temperature

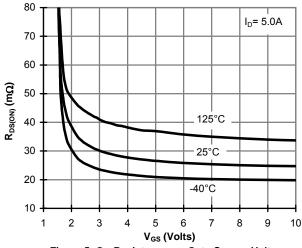


Figure 5: On-Resistance vs. Gate-Source Voltage

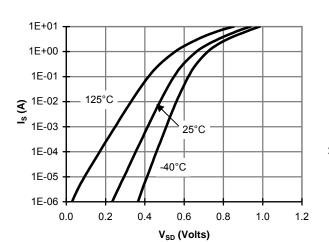
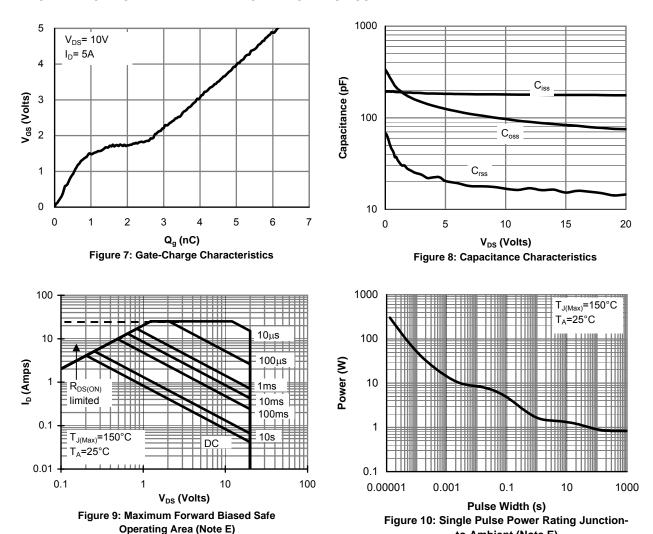


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



10 D=T_{on}/T In descending order D=0.5, 0.3, 0.1, 0.05, 0.02, 0.01, single pulse D=0.5, 0.05, 0.02, 0.01, single pulse D=0.5, 0.05, 0.02, 0.01, single pulse D=0.5, 0.05, 0.02

Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance(Note E)

0.1

0.0001

0.001

0.01

0.0001

1000

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to-Ambient (Note E)

10

100